

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/713,627	<b>Applicant(s)/Patent under Reexamination</b> KARR ET AL.
	<b>Examiner</b> Duc M. Nguyen	<b>Art Unit</b> 2685

SEARCHED			
Class	Subclass	Date	Examiner
455	550 552.1 553.1		
	556.1		
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	41.2 41.3		
	515 102		
	108 110		
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	226.2		
	205 208		
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Updated	10/20/06	DOV	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner